# MOSFET – Power, Single, N-Channel, SO-8 FL 30 V, 52 A

### Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

### Applications

- CPU Power Delivery
- DC-DC Converters

### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise stated)

	<b></b> (1) = 2		er mee etate	ч)	-
Para	meter		Symbol	Value	Unit
Drain-to-Source Volt	age		V <sub>DSS</sub>	30	V
Gate-to-Source Volta	age		V <sub>GS</sub>	±20	V
Continuous Drain Current R <sub>θJA</sub>		T <sub>A</sub> = 25°C	I <sub>D</sub>	16.4	A
(Note 1)		$T_A = 80^{\circ}C$		12.3	
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	PD	2.51	W
Continuous Drain Current $R_{\theta,JA} \le 10 \text{ s}$		T <sub>A</sub> = 25°C	۱ <sub>D</sub>	25.3	A
(Note 1) (Note 1)		$T_A = 80^{\circ}C$		19.0	
Power Dissipation $R_{\theta JA} \leq 10 \text{ s} \text{ (Note 1)}$	Steady	T <sub>A</sub> = 25°C	PD	6.0	W
Continuous Drain Current R <sub>θ.IA</sub>	State	$T_A = 25^{\circ}C$	I <sub>D</sub>	9.0	A
(Note 2)		$T_A = 80^{\circ}C$		6.8	
Power Dissipation $R_{\theta JA}$ (Note 2)		T <sub>A</sub> = 25°C	PD	0.76	W
Continuous Drain		$T_{C} = 25^{\circ}C$	۱ <sub>D</sub>	52	Α
Current R <sub>θJC</sub> (Note 1)		T <sub>C</sub> =80°C		39	
Power Dissipation $R_{\theta JC}$ (Note 1)		T <sub>C</sub> = 25°C	PD	25.5	W
Pulsed Drain Current	T <sub>A</sub> = 25°	<sup>2</sup> C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	146	A
Current Limited by Pa	ickage	$T_A = 25^{\circ}C$	I <sub>Dmax</sub>	80	Α
Operating Junction ar Temperature	nd Storage		T <sub>J</sub> , T <sub>STG</sub>	–55 to +150	°C
Source Current (Body	<sup>,</sup> Diode)		۱ <sub>S</sub>	23	А
Drain to Source dV/dt		dV/d <sub>t</sub>	7.0	V/ns	
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, V <sub>GS</sub> = 10 V, I <sub>L</sub> = 29 A <sub>pk</sub> , L = 0.1 mH, R <sub>GS</sub> = 25 $\Omega$ ) (Note 3)		E <sub>AS</sub>	42	mJ	
	Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		ΤL	260	°C

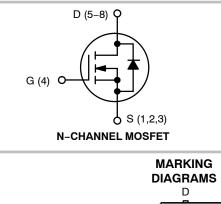
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



# **ON Semiconductor®**

### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
30 V	$4.73~\mathrm{m}\Omega @~10~\mathrm{V}$	52 A
30 V	7.0 mΩ @ 4.5 V	52 A





#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMFS4C028NT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NTMFS4C028NT3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

1

- $1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu. \\ 2. Surface-mounted on FR4 board using the minimum recommended pad size. \\ 3. Parts are 100% tested at T_J = 25°C, V_{GS} = 10 V, I_L = 20 A_{pk}, EAS = 20 mJ. \\$

# THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	4.9	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	49.8	°C 444
Junction-to-Ambient - Steady State (Note 5)	$R_{\theta JA}$	164.6	°C/W
Junction-to-Ambient – (t $\leq$ 10 s) (Note 4)	$R_{\thetaJA}$	21.0	

4. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

5. Surface-mounted on FR4 board using the minimum recommended pad size.

#### ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					-	-	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu$ A		30			V
Drain-to-Source Breakdown Voltage (transient)	V <sub>(BR)DSSt</sub>	$V_{GS}$ = 0 V, $I_{D(aval)}$ = 8.4 A, $T_{case}$ = 25°C, $t_{transient}$ = 100 ns		34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				14.4		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$			1.0	μΑ
		$V_{DS} = 24 V$	T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 6)					•		
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS}$ = $V_{DS}$ , $I_D$ = 250 $\mu$ A		1.3		2.1	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.8		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		3.9	4.73	mΩ
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 18 A		5.8	7.0	
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A			50		S
Gate Resistance	R <sub>G</sub>	T <sub>A</sub> = 25°C		0.3	1.0	2.0	Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				1252		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MH	z, V <sub>DS</sub> = 15 V		610		
Reverse Transfer Capacitance	C <sub>RSS</sub>	1			126		1
Capacitance Ratio	C <sub>RSS</sub> /C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 15	V, f = 1 MHz		0.101		
Total Gate Charge	Q <sub>G(TOT)</sub>				10.9		
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			1.9		nC
Gate-to-Source Charge	Q <sub>GS</sub>				3.4		
Gate-to-Drain Charge	Q <sub>GD</sub>				5.4		
Gate Plateau Voltage	V <sub>GP</sub>				3.1		V
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			22.2		nC

#### SWITCHING CHARACTERISTICS (Note 7)

6. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

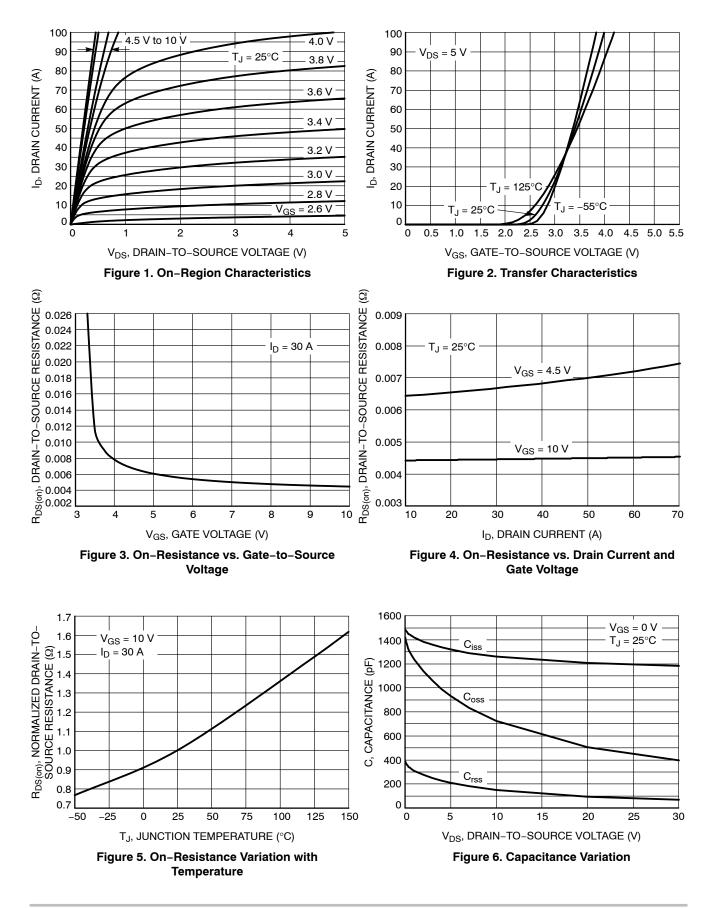
7. Switching characteristics are independent of operating junction temperatures.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	lote 7)					1	
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 15 V, I <sub>D</sub> = 15 A, R <sub>G</sub> = 3.0 $\Omega$			10		ns
Rise Time	tr				32		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				16		
Fall Time	t <sub>f</sub>				6.0		
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, I <sub>D</sub> = 15 A, R <sub>G</sub> = 3.0 Ω			7.0		ns
Rise Time	tr				28		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				20		
Fall Time	t <sub>f</sub>				4.0		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.79	1.1	
		$I_{\rm S} = 10  \rm A$	T <sub>J</sub> = 125°C		0.65		V
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/μs, I <sub>S</sub> = 30 A			31		
Charge Time	t <sub>a</sub>				15		ns
Discharge Time	t <sub>b</sub>				16		
Reverse Recovery Charge	Q <sub>RR</sub>				15		nC

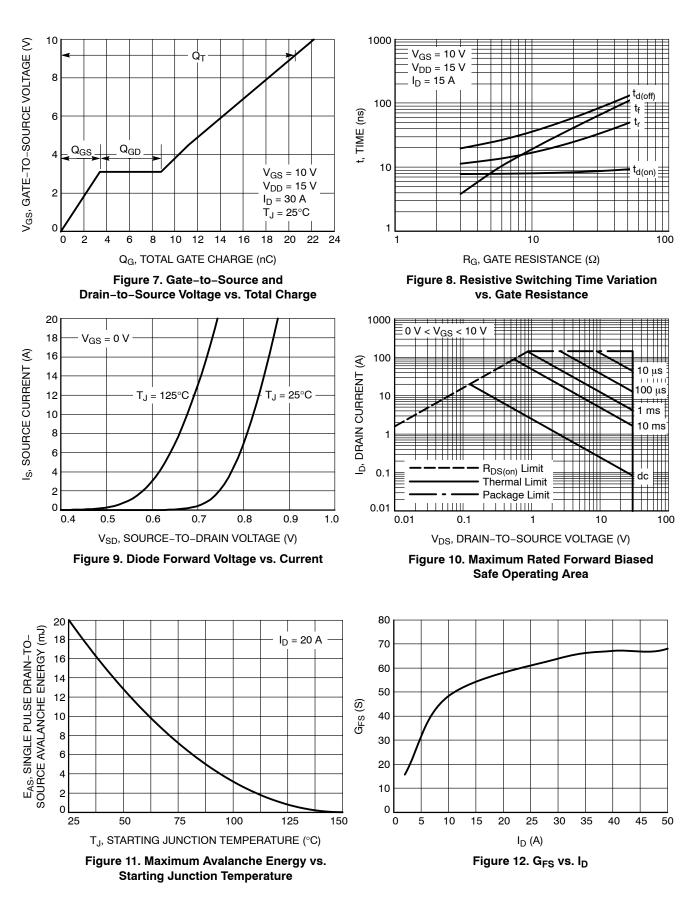
 $\begin{array}{ll} \mbox{6. Pulse Test: pulse width } \le 300 \ \mu \mbox{s, duty cycle } \le 2\%. \\ \mbox{7. Switching characteristics are independent of operating junction temperatures.} \end{array}$ 

## **TYPICAL CHARACTERISTICS**



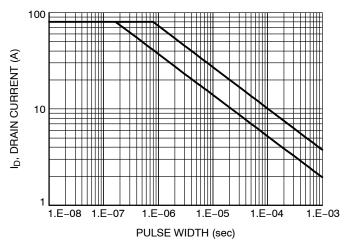
www.onsemi.com 4

#### **TYPICAL CHARACTERISTICS**

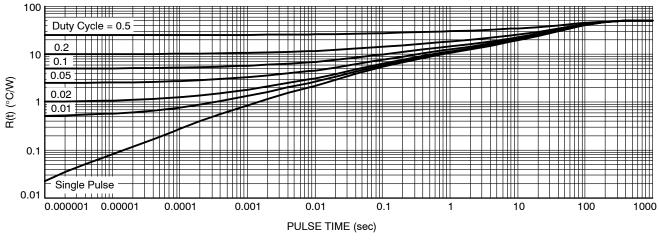


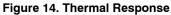
<u>www.onsemi.com</u> 5

# **TYPICAL CHARACTERISTICS**



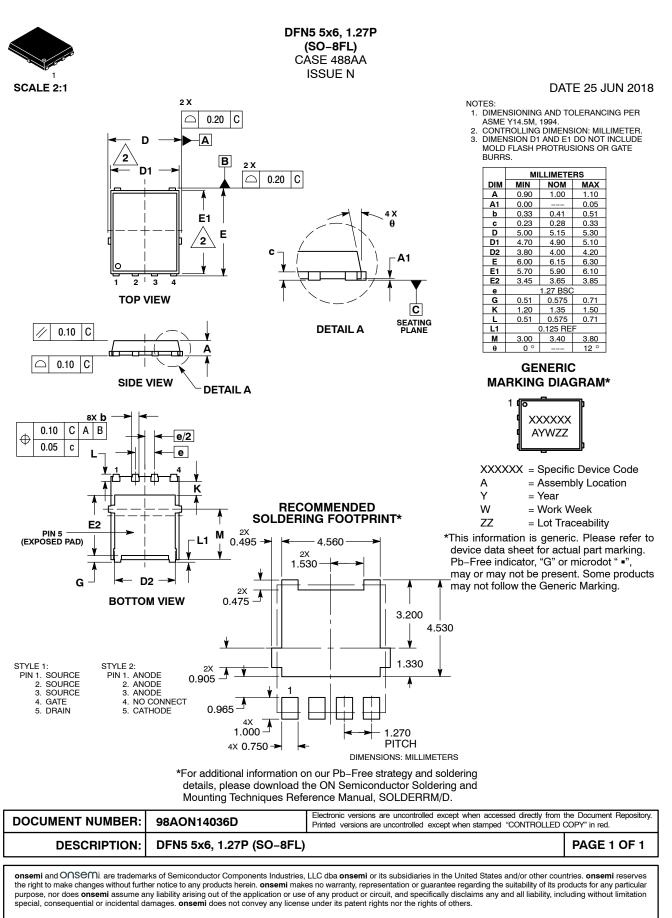






<u>www.onsemi.com</u> 6

# onsemi



© Semiconductor Components Industries, LLC, 2018

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights or the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use onsemi products for any such u

#### ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

Technical Library: www.onsemi.com/design/resources/technical-documentation onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at www.onsemi.com/support/sales 单击下面可查看定价,库存,交付和生命周期等信息

>>ON Semiconductor(安森美)